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Transparent flexible thermoelectric material based on non-toxic earth-abundant p-type copper iodide thin film

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Thermoelectric devices that are flexible and optically transparent hold unique promise for future electronics. However, development of invisible thermoelectric elements is hindered by the lack of p-type transparent thermoelectric materials. Here we present the superior room-temperature thermoelectric performance of p-type transparent copper iodide (CuI) thin films. Large Seebeck coefficients and power factors of the obtained CuI thin films are analysed based on a single-band model. The low-thermal conductivity of the CuI films is attributed to a combined effect of the heavy element iodine and strong phonon scattering. Accordingly, we achieve a large thermoelectric figure of merit of $ZT = 0.21$ at 300 K for the CuI films, which is three orders of magnitude higher compared with state-of-the-art p-type transparent materials. A transparent and flexible CuI-based thermoelectric element is demonstrated. Our findings open a path for multifunctional technologies combining transparent electronics, flexible electronics and thermoelectricity.

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Thermoelectric energy recovery in room temperature range has attracted significant interest because of the usages of numerous heat sources near room temperature such as consumer electronics, solar cells, home heating and wearable devices on human bodies. Generally, heavily doped semiconductors with an energy bandgap value E_g close to $10k_B T_O$ can be used as good thermoelectric materials, where k_B is the Boltzmann constant and T_O the operating temperature¹. As a matter of fact, most established thermoelectric materials tend to be optically opaque due to their small bandgap ($E_g \ll 2$ eV), such as the $(\text{Bi,Sb})_2\text{Te}_3$ family^{2,3}. Several classes of non-transparent thermoelectric materials with attractive thermoelectric properties for renewable power generation applications were recently reported, including tellurides⁴, half-Heuslers⁵ and silicides⁶. Up to date, few optically transparent ($E_g > 3$ eV) thermoelectric devices are known to exist, whereas realization of such invisible devices could open new fields in a range of novel applications such as smart windows (or screens) with energy harvesting, cooling and thermal sensing functionalities. Another potential application of transparent thermoelectric elements is the fast on-chip cooling and power recovery^{7,8} for optoelectronic devices including solar cells, infrared photodetectors, as well as fully transparent electronic devices.

Good thermoelectric properties are expected for a large dimensionless figure of merit (ZT).

$$ZT = S^2 \sigma T \kappa^{-1} \quad (1)$$

The value of ZT is calculated from the Seebeck coefficient S , electrical conductivity σ , temperature T and thermal conductivity κ . Accordingly, a transparent thermoelectric material is primarily a transparent conductor (TC) with a high value of S and a low value of κ . Since the conventional thermoelectric modules consist of coupled n- and p-type thermoelectric legs, both n- and p-type transparent thermoelectric materials are required. However, due to the lack of highly conductive p-type TCs, recent research has focused on thermoelectric properties of n-type TCs including heavily doped ZnO (ref. 9), In_2O_3 (ref. 10) and SrTiO_3 (ref. 11). Among these n-type TCs, Sn-doped In_2O_3 (ITO) shows the highest value of $ZT \sim 0.14$ at room temperature¹⁰. On the other hand, p-type TCs usually exhibit poor electrical conductivities σ , which are several orders of magnitude smaller than those of n-type TCs, leading to poor thermoelectric performance at room temperature, for example, $ZT \sim 0.001$ for CuAlO_2 (ref. 12) and $ZT \sim 0.002$ for CuCrO_2 (ref. 13). The p-type misfit-layered oxide $\text{Ca}_3\text{Co}_4\text{O}_9$ was reported to possess thermoelectric performance ($ZT \sim 0.07$ at room temperature for single crystal) comparable to those of the n-type TCs, but it is not truly transparent due to its small bandgap ($E_g \sim 2.1$ eV)¹⁴. Consequently, the lack of p-type transparent thermoelectric materials is the main obstacle in realization of fully transparent thermoelectric devices.

In this study, we focus on the room-temperature thermoelectric performances of copper iodide (CuI) thin films, since CuI in its ground-state phase was recently reported as a high performance p-type TC material^{15–17}. CuI is an environment-friendly material composed of non-toxic and naturally abundant elements. Present in sea water, iodine is the heaviest essential element used widely in daily life for biological functions. Interestingly, the presence of heavy elements like iodine leads to a low thermal conductivity, which is necessary for a good thermoelectric performance. CuI undergoes multiple polymorphic phase transitions during heating, that is, γ (zincblende structure, space group $F43m$) $\rightarrow$ β (wurtzite structure, $P6_3mc$) $\rightarrow$ α (rock salt structure, $Fm3m$) at 643 K and 673 K, respectively¹⁸. In the α - or β -phase, it acts as a superionic conductor which is regarded as a phonon-liquid material with a low-thermal conductivity¹⁹. Whereas in its γ -phase at room temperature

(or below 643 K), it is a wide direct bandgap ($E_g = 3.1$ eV) semiconductor with p-type conductivity. The copper vacancy, which has a shallow acceptor level, is primarily responsible for p-type conductivity of γ -CuI (ref. 15). Very recently a record high room-temperature hole conductivity $\sigma > 280 \text{ S cm}^{-1}$ has been achieved for CuI thin film¹⁷. At 300 K, a large Seebeck coefficient of γ -CuI ($S = 237 \mu\text{V K}^{-1}$ for a hole concentration p of 10^{20} cm^{-3}) was theoretically predicted based on the Boltzmann transport theory combining with first-principles calculations²⁰. Consequently, a high thermoelectric performance in the wide bandgap γ -CuI can be expected owing to its high values of σ (with respect to the large bandgap) and S , as well as the predictable low value of κ . For the purpose of exploring truly transparent p-type thermoelectric materials, the thermoelectric properties of γ -CuI thin films have been investigated in this work. We report the superior thermoelectric performance of transparent p-type γ -CuI thin films in room temperature range. The thermoelectric transport properties of γ -CuI are analysed based on the single-band model. Furthermore, a prototype of CuI-based transparent and flexible thermoelectric module is demonstrated.

Results

Superior thermoelectric performance of CuI thin films. γ -CuI is a native p-type conductor due to the existence of copper vacancies with a high hole mobility ($\mu > 40 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ in bulk material) owing to the fairly small effective mass of $0.30 m_0$ for light holes^{15,21}. The heavy-hole band of γ -CuI does not explicitly reduce the hole mobility μ because it degenerates with the light-hole band under a strain-free condition. The single type of carrier (hole) in γ -CuI is favourable for a large Seebeck coefficient S (ref. 22). The obtained γ -CuI samples in this study (see Supplementary Note 1 and Supplementary Fig. 1) are polycrystalline thin films deposited on glass and flexible polyethylene terephthalate (PET) substrates, which is consistent with our previous reports^{16,17}. The hole concentration of γ -CuI was controlled by varying the iodine partial pressure in the sputter chamber during the deposition¹⁷. Figure 1a shows the S values of γ -CuI on glass as a function of hole concentration p at 300 K. The plot of experimental values of S versus p from this work (red squares in Fig. 1a) follows precisely the reported theoretical trend obtained based on the Boltzmann theory²⁰ (dashed line in Fig. 1a). These theoretical S values are relatively over-estimated due to the under-estimated bandgap (theoretical $E_g = 2.23$ eV) in the first-principles calculations using local or semi-local approximations²⁰. The difference between our experimental data and theoretical data is about $75 \mu\text{V K}^{-1}$. For the experimental data reported in reference²³, the S value of an as-prepared γ -CuI thin film is very close to our data, but becomes smaller than our S values after post-annealing. Higher annealing temperature leads to a lower value of p and even larger deviations in value of S . Such deviations might be related to the formation of defects (that is, iodine vacancies and electrically neutral defect complexes) during the post-annealing²³.

The Seebeck coefficient S of a p-type semiconductor can be obtained using the Pisarenko formula¹:

$$S = \frac{k_B}{e} \left(A + \ln \frac{2(\pi m^* k_B T)^{3/2}}{ph^3} \right) \quad (2)$$

where A is the scattering parameter, p is the hole concentration, m^* is the effective mass of the carrier, e is the elementary charge and h is the Planck constant¹. For γ -CuI, the theoretical (directionally averaged) effective masses of electrons and light holes are $0.30 m_0$ and those of the heavy holes are $2.14 m_0$ (ref. 21). Thus, the large S value of the γ -CuI is attributed to a large effective mass m^* which is dominated by the heavy-hole band. According to the theoretical S data (dashed line in Fig. 1a),

Figure 1 | Thermoelectric properties of the p-type CuI thin films. (a) Seebeck coefficients S , (b) hole mobility μ , (c) power factor PF, (d) thermal conductivity κ and (e) figure-of-merit ZT of γ -CuI thin films (thickness of 300 nm) deposited on glass as a function of hole concentration p at 300 K. (f) Figure-of-merit ZT of γ -CuI thin films deposited on glass near room temperature. In a the solid line is a fit with equation (4). In b and e the dashed line is a guide to eye indicating the averaged hole mobility μ_{ave} or the saturation of ZT . In (c) the solid line is derived from the calculation using equation (6) with a single-band model, and the dashed line presents the theoretical data taking into account the non-parabolicity of the bands.

the flattening phenomenon at around $100 \mu\text{V K}^{-1}$ for hole concentrations greater than $5 \times 10^{20} \text{ cm}^{-3}$ is related to the increased effective mass m^* of heavily doped γ -CuI. In such a high p region, the large value of hole density would move the Fermi level deeper into the valance band, resulting in a higher effective mass m^* . However, due to the limited hole density of $P < 2 \times 10^{20} \text{ cm}^{-3}$ in this work, the value of hole mobility μ (Fig. 1b) does not vary much within such a hole density range, indicating a relatively constant effective mass m^* . Hence, the single-band model is adopted here for the Boltzmann approximation and a parabolic valance band²⁴, thus resulting in a linear relationship of S versus $\ln p$. Accordingly, equation (2) can be rewritten into:

$$S = \frac{k_B}{e} \left(A + \ln \frac{2(2\pi m^* k_B T)^{3/2}}{h^3} \right) - \frac{k_B}{e} \ln p \quad (3)$$

or can be simplified into:

$$S = C - (86.17 \mu\text{V K}^{-1}) \ln(p \text{ cm}^{-3}) \quad (4)$$

where the plot of S versus $\ln p$ shows a straight line with a slope of $-k_B/e$ or $-86.17 \mu\text{V K}^{-1}$. Thereby a Pisarenko plot (solid line

in Fig. 1a) can be derived from equation (4) with a fixed slope of $-86.17 \mu\text{V K}^{-1}$, which fits well with the experimental data in this work. The fitting parameter C is equal to $4128 \pm 3 \mu\text{V K}^{-1}$. Accordingly, the value of scattering parameter A can be determined to be 2.05, indicating ionized-impurity scattering in the obtained γ -CuI thin films¹⁵.

For p-type semiconductors with negligible electron conduction, the conductivity value σ can be obtained from:

$$\sigma = e\mu p \quad (5)$$

Therefore, the value of thermoelectric power factor $\text{PF} = S^2\sigma$ can be calculated by combining equations (4) and (5) as:

$$\text{PF} = e\mu p [4128 \mu\text{V K}^{-1} - (86.17 \mu\text{V K}^{-1}) \ln(p \text{ cm}^{-3})]^2 \quad (6)$$

The value of μ is considered here as a constant with an average value of $8.3 \text{ cm}^2 \text{V}^{-1} \text{s}^{-1}$, as shown in Fig. 1b. With this approximation, the PF can be calculated using equation (6) as a function of p . Figure 1c shows the calculated room-temperature PF values of the γ -CuI using the single-band model (solid line), which are consistent with the experimental results. The estimated maximum PF value is $3.59 \times 10^{-4} \text{ W m}^{-1} \text{K}^{-2}$ at which

$p = 1 \times 10^{20} \text{ cm}^{-3}$ and $S = 172 \mu\text{V K}^{-1}$. The highest experimental value of PF in this work is $3.75 \times 10^{-4} \text{ W m}^{-1} \text{ K}^{-2}$ at 300 K, which is comparable with those of the n-type TCs such as Al-doped ZnO ($3.9 \times 10^{-4} \text{ W m}^{-1} \text{ K}^{-2}$) (ref. 9).

Because of the relatively low-hole concentrations of the films in this study, we could not further evaluate the thermoelectric properties of heavily (intrinsic) doped γ -CuI. The dashed line in Fig. 1c presents the theoretical values of PF at room temperature taking into account the non-parabolicity of the bands²⁰ for heavily doped γ -CuI, indicating that even larger PF values are achievable for highly degenerate γ -CuI (with hole concentration $p \gg 1 \times 10^{20} \text{ cm}^{-3}$). We note that the degeneracy of the heavy- and light-hole bands of γ -CuI is beneficial for a good thermoelectric performance because it simultaneously leads to a high Seebeck coefficient S and a high electrical conductivity σ .

To determine the ZT value, knowledge of the thermal conductivity κ of the γ -CuI thin film is required. The lower the value of κ , the higher the ZT will be. However, the κ value of γ -CuI has never been reported to the best of our knowledge. In general, the thermal conductivity κ of a semiconductor originates from two sources: (1) κ_e , which is linked to heat transport from electron and hole current and (2) κ_{ph} , which is linked with phonon scattering. According to the Wiedemann–Franz law²⁵, κ is given by:

$$\kappa = \kappa_e + \kappa_{ph} = \sigma LT + \kappa_{ph}, \quad (7)$$

where L is the Lorenz factor, $2.4 \times 10^{-8} \text{ W } \Omega \text{ K}^{-2}$ for ideal metals and $1.5 \times 10^{-8} \text{ W } \Omega \text{ K}^{-2}$ for ideal non-degenerate semiconductors²⁵. Here the non-degenerate L is adopted, and thus the calculated value of κ_e for γ -CuI ranges from 0.02 to $0.06 \text{ W m}^{-1} \text{ K}^{-1}$ depending on the hole concentration p . On the other hand, the value of κ_{ph} is independent of electrical

properties. By using a developed 3 ω method in this study²⁶, the total thermal conductivity κ of the CuI sample with PF of $3.75 \times 10^{-4} \text{ W m}^{-1} \text{ K}^{-2}$ has been determined, as low as $0.55 \text{ W m}^{-1} \text{ K}^{-1}$ near room temperature. This κ value is even lower than that of glass²⁷ or phonon–liquid material Cu_2Se (ref. 19) ($\kappa \sim 1.0 \text{ W m}^{-1} \text{ K}^{-1}$ at room temperature). Thereby, we can estimate a κ_{ph} value around $0.5 \text{ W m}^{-1} \text{ K}^{-1}$. Such a low κ_{ph} value is attributed to the heavy element iodine, as well as the strong phonon scattering at grain boundaries due to the polycrystalline nature of the γ -CuI thin films. The total thermal conductivity κ of the γ -CuI thin film with different hole concentrations p can be estimated by equation (7), as shown in Fig. 1d, where the κ value slightly increases with increasing p .

Subsequently, the thermoelectric ZT values of the γ -CuI thin films on glass are calculated using equation (1). Figure 1e shows the carrier density dependence of ZT at room temperature. The values of ZT increase with increasing hole density p , and then reach a saturation point at $p > 5 \times 10^{19} \text{ cm}^{-3}$. The maximum ZT at 300 K is around 0.21, which is comparable with that of p-type PbTe ($ZT \sim 0.3$ in bulk²⁸). The thermoelectric performance of the CuI thin films could be further enhanced at slightly elevated temperatures, as shown in Fig. 1f. The values of σ and S for these films can be found in Supplementary Fig. 2. The room-temperature κ value was used to calculate the ZT values at such slightly elevated temperatures. The value of ZT is estimated up to 0.23 at around 330 K. Considering the diffusion of iodine (and other defects) in γ -CuI thin films during heat treatment, as described in ref. 23, higher heating temperatures over 350 K frequently lead to degraded electrical conductivity of γ -CuI. Hence, a capping (protective) layer is required to improve the thermal stability of γ -CuI thin film at further elevated temperatures. For example, as shown in Supplementary Note 2

Figure 2 | Transparency and flexibility of the CuI thin films. (a) Transmittance spectra of CuI thin film (thickness of 300 nm) deposited on glass. Inset is the $(\alpha hv)^2$ versus $h\nu$ plot of CuI thin film. (b) The actual photo and (c) internal resistance R_{int} stability of a CuI thin film sample deposited on PET with different bending angles. (d) The reliability test by repeated bending cycles.

Figure 3 | A CuI-based single-leg thermoelectric module. (a) Schematic illustration for the power output measurement of the CuI/PET single-leg thermoelectric device. (b) The example infrared image taken during one of the measurements. The electrical contacts appear cold in the image because of their different emissivity compared with CuI. (c) Output voltage V_{out} and output power P_{out} of a CuI-based thermoelectric leg as a function of output current I_{out} for three temperature differences.

Figure 4 | Figure of merit versus energy bandgap. Comparing the thermoelectric ZT of typical n- and p-type thermoelectric materials and γ -CuI thin films (this work) at room temperature. Dashed line is guide to the eyes. Detailed data see Supplementary Table 1.

and Supplementary Fig. 3, the degradation of the conductivity of γ -CuI thin film during air-annealing could be significantly suppressed by capping with a CuO_x layer. It shows a three times reduced effect of increasing resistance and thus proves that further technological work targeted towards capping can extend the range of useful operation temperatures. Detailed study on the thermal stability of CuI are subject to further investigations by design and development of suitable capping layers. Although high-temperature thermoelectric performance of CuI is beyond the scope of this study, we note that molten CuI has been found to exhibit a large value of ZT over 0.1 due to the large Seebeck coefficient $620\text{--}890\ \mu\text{V K}^{-1}$ and small thermal conductivity $0.57\ \text{W m}^{-1}\text{K}^{-1}$ at high temperature ($900\text{--}1150\ \text{K}$)²⁹.

The transparency and flexibility of CuI thin films. The optical transparency of the γ -CuI sample can be confirmed by the optical transmittance spectra as shown in Fig. 2a, where the transmittance, exhibiting interference effects due to film thickness, is $\sim 60\text{--}85\%$ over the visible and near infrared regions (wavelength of $410\text{--}2,000\ \text{nm}$). We also estimate the bandgap E_g of the obtained γ -CuI sample using Tauc's equation³⁰:

$$\alpha h\nu = B(h\nu - E_g)^m \quad (8)$$

where α is the optical absorption coefficient, $h\nu$ is the photon energy, B is a constant, m is $1/2$ for a direct band transition and 2 for an indirect band transition³⁰. The inset in Fig. 2a presents a linear relationship between $(\alpha h\nu)^2$ and $h\nu$, indicating a direct energy bandgap of the γ -CuI thin film. The value of E_g is determined to be about $3.02\ \text{eV}$, which is consistent with that of bulk γ -CuI (ref. 15). Such a wide direct bandgap $E_g > 3.0\ \text{eV}$ allows for the full transparency of γ -CuI in the visible spectral range.

The mechanical flexibility of γ -CuI film deposited on PET has been investigated, and the results are shown in Fig. 2b–d. We found that compressive stress leads to an improved electrical conductivity, whereas tensile stress results in a degraded electrical conductivity. This phenomenon can be explained by the enhanced (or worsened) compactness of the grains in the polycrystalline γ -CuI thin film under a compressive (or tensile) strain. The change of the internal resistance R_{int} is $< 3\%$ with a compressive bending angle up to 90° , and $< 0.2\%$ after repeatedly bent up to 400 cycles. These results indicate that the CuI-based thermoelectric modules can properly work on curved thermal energy sources such as hot-water tubes, clothes and human bodies.

A transparent single-leg thermoelectric module. A prototype of the transparent thermoelectric module has been fabricated as a demonstrator, which consists of a single thermoelectric leg of γ -CuI thin film on PET substrate, as illustrated in Fig. 3a,b. We note that practical thermoelectric devices are constructed by coupling the n- and p-type thermoelectric legs. Here the single-leg setup is only used to evaluate the output characteristics of CuI-based thermoelectric modules. The output characteristics of such a demonstrator are shown in Fig. 3c for three temperature differences ($\Delta T = 4.7, 8.5$ and $10.8\ \text{K}$), and the simulated curves fit the experimental data well. This single thermoelectric leg generates a maximum power output of $8.2\ \text{nW}$ at $\Delta T = 10.8\ \text{K}$. Accordingly, the estimated power density of $0.10\ \text{mW cm}^{-2}$ at $\Delta T = 10.8\ \text{K}$ or $2.4\ \text{mW cm}^{-2}$ at $\Delta T = 50\ \text{K}$ is comparable with those for $\text{Bi}_2\text{Te}_3/\text{Sb}_2\text{Te}_3$ -based devices^{31,32}. The details for simulation of the maximum power output at a certain temperature difference are described in Supplementary Note 3 and shown in Supplementary Fig. 4. We also evaluated the energy conversion efficiency of this module, as described in Supplementary Note 4, and the results are shown in Supplementary Fig. 5. A conversion efficiency of 0.8% for the CuI-based module is obtained at $\Delta T = 50\ \text{K}$, which is close to that for p-type PbTe-based module ($\sim 1\%$) at the same temperature difference²⁸.

Discussion

The above results indicate that the CuI-based thermoelectric module is promising for low-power applications, such as body-heat-powering for wearable devices, thermoelectric windows, and on-chip cooling or power recovery for miniaturized chips. For example, the CuI-based thermoelectric module can generate a power density of $20 \mu\text{W cm}^{-2}$ at $\Delta T = 5 \text{ K}$, which is sufficient to run wearable devices such as electric watches, accelerometers, ozone sensors, blood-pressure monitors and electrocardiogram sensors. The power consumption of such small devices is approximately $10\text{--}150 \mu\text{W}$ (ref. 33), which can be provided by CuI-based thermal batteries with an area of several cm^2 .

Another example is large-area thermoelectric windows for sustainable renewable power generation. The transparent CuI-based thermoelectric elements could generate energy density of around 0.1 kWh m^{-2} every day with a temperature gradient of 20 K between indoor and outdoor environments of a building. Hence, in theory, such a thermoelectric window with an area of about 10 m^2 could run a refrigerator all day long (electricity consumption of about 1 kWh per day), saving about 100 Euro per year for a household in Germany (electricity price of $0.297 \text{ Euro per kWh}$, data from Eurostat 2016). For office buildings with generally high window-to-wall ratios, much more electricity expenses would be saved by applying our designed thermoelectric windows.

We compared the bandgap E_g and room-temperature ZT for typical thermoelectric materials in Fig. 4 (see detailed data in Supplementary Table 1). Among transparent materials ($E_g > 3 \text{ eV}$), p-type $\gamma\text{-CuI}$ thin film exhibits a 1,000 times improvement of the ZT compared to those of any other p-type material such as CuAlO_2 (ref. 12), and almost twice compared to those of n-type materials, such as Al-doped ZnO ⁹ and ITO ¹⁰. Nevertheless, the thermoelectric properties of CuI can be further improved: for example, it is possible to enhance the ZT of the CuI by increasing its hole density, which is limited to around $1 \times 10^{20} \text{ cm}^{-3}$ in this work due to unintentional doping. Taking into account the non-parabolicity of the bands²⁰ for heavily doped $\gamma\text{-CuI}$, a much higher hole density (well above $1 \times 10^{20} \text{ cm}^{-3}$) is required to improve the power factor and thereby the ZT value. For this purpose, we suggest to use the extrinsic doping method which is widely used to produce highly degenerate semiconductors, for example, degenerating ZnO doped with Al or Ga. Anion dopants such as N, P, O, S and Se can be good candidates for extrinsic doping of the CuI.

Another generic approach for ZT enhancement is to prepare CuI in the form of nanostructures, such as thin-film superlattices², quantum-dot superlattices³, nanocomposites³⁴ and heterostructures³⁵. In our previous work, we have realized nanostructured CuI, as well as the heteroepitaxial growth of CuI thin films on various substrates or semiconductor thin films^{16,17}. Consequently, various types of nanostructures and multilayers of CuI could be realized in order to achieve higher ZT values.

In conclusion, transparent p-type $\gamma\text{-CuI}$ thin films exhibit high thermoelectric performance in room temperature range^{36,37}. Large Seebeck coefficients are observed and fitted well with the single-band model. The low-thermal conductivity near room temperature is attributed to the heavy element iodine, as well as the strong phonon scattering within the obtained polycrystalline $\gamma\text{-CuI}$ thin films. At the same time, these films are transparent and exhibit a high transmission of $60\text{--}85\%$ in the visible spectral range. Accordingly, we have achieved a high thermoelectric figure of merit $ZT \sim 0.23$ near room temperature for this transparent film material, which is 1,000 times higher compared to any other p-type transparent material and almost twice compared to n-type materials. A prototype of CuI-based transparent thermoelectric module shows a good mechanical flexibility with a high power

density of 2.4 mW cm^{-2} at $\Delta T = 50 \text{ K}$, which is comparable with those for $\text{Bi}_2\text{Te}_3/\text{Sb}_2\text{Te}_3$ -based devices. These results show the great potential of $\gamma\text{-CuI}$ as a transparent flexible thermoelectric material. In combination with available n-type transparent thermoelectric materials, such as Al-doped ZnO and Sn-doped In_2O_3 , invisible thermoelectric modules can be readily constructed by coupling the transparent n- and p-type thermoelectric legs. Such invisible and flexible thermoelectric element can be used for designs of thermoelectric windows, body-heat-powered wearable devices, and on-chip cooling or power recovery for miniaturized chips. The sputtering technique at room temperature used here can be upscaled for producing large area transparent CuI thin films on low-cost flexible and transparent substrates.

Methods

Sample preparation and structural characterization. Polycrystalline CuI films were deposited on Corning 1737 glass and PET substrates by reactive sputtering at room temperature. A high purity (99.999%) copper disk was used as the sputtering target. Iodine vapour was introduced by a needle valve connected with a heated iodine source. This iodine source was a stainless steel tube filled with iodine particles, which was kept at 180°C to sustain a sufficient iodine vapour pressure. Argon was introduced to get the total pressure to 0.02 millibar. The experimental details were also described in our previous report^{16,17}. The thickness of the CuI thin film was estimated using a Dektak profilometer.

Property measurements. Room-temperature Hall effect was measured in Van-der-Pauw geometry with a magnetic field of 0.4 T to determine the carrier type, density and mobility. For investigation of thermoelectric properties, S and σ were measured simultaneously under helium atmosphere with a Linseis LSR-3 instrument with NiCr/Ni and Ni contacts and a continuous reverse of the polarity of the thermocouples (bipolar setup). The in-plane thermal conductivities of the CuI thin films were determined using the differential 3ω method²⁶. The optical transmission spectra were measured using a PerkinElmer Lambda 40 ultraviolet-VIS-near infrared spectrometer between a wavelength of 200 and $2,000 \text{ nm}$. The thermoelectric power output of the single-leg demonstrator was measured using a hot plate to create a temperature gradient and simultaneously measuring the temperature difference using an infrared camera FLIR E50. The voltage and current generated between two Au metal contacts was measured using a multimeter. The output voltage and power of the module were measured by changing the load resistance and temperature difference near room temperature. The power density was evaluated with a fixed thin film cross-sectional area ($8 \times 10^{-5} \text{ cm}^2$).

Data availability. The data that support the findings of this study are available from the corresponding author on reasonable request.

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Author contributions

C.Y. and M.G. conceived and designed the research. C.Y. performed the experiments, analysed the data and wrote the paper. M.K. and M.L. contributed sputtering techniques. D.S. and O.O. conducted the Seebeck effect measurement. H.M.W. contributed the Hall effect measurement. M.B., G.B. and Y.Q.F. carried out the thermal conductivity measurement. All authors discussed the results and commented on the manuscript.

Additional information

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